

ID	R _{DS} (ON)(Typ)	VDSS
7A	1.1Ω	500V

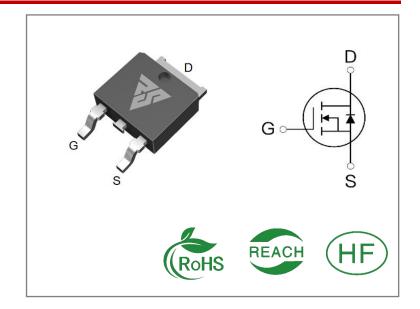
Applications:

- Switch Mode Power Supply(SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)

Features:

- Fast switching speed
- 100% avalanche tested
- Improved dv/dt capability
- Fast Recovery Time





Part Number	Package Marking		Packing	Qty.	
RSF7N50D	T0-252	RSF7N50D	Tape&reel	2500 PCS	

Absolute Maximun Ratings Tc= 25 ℃ unless otherwise specified

Symbol	Parameter	RSF7N50D	Units	
VDSS	Drain-to-Source Voltage	500	V	
ID	Continuous Drain Current TC=25℃	7		
IDM	Pulsed Drain Current (Note*1)	28	A	
PD	Power Dissipation	99	W	
VGS	Gate- to- Source Voltage	±30	V	
EAS	Single Pulse Avalanche Engergy L = 10mH, VDD = 50V, RG = 25 Ω,TC=25°C	240	mJ	
	Maximum Temperature for Soldering	300		
TL TPKG	Leads at 0.063in(1.6mm)from Case for 10 seconds	260	•	
	Package Body for 10 seconds		$^{\circ}$ C	
TJ and	Operating Junction and Storage	-55 to 150		
TSTG	Temperature Range	-35 (0.130		

^{*} Drain Current Limited by Maximum Junction Temperature

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" Table may cause permanent damage to the device.



Thermal Resistance

Symbol	Parameter	RSF7N50D	Units	Test Conditions
				Drain lead soldered to water cooled
RθJC	Junction-to-Case	1.58	°C/W	heatsink, PD adjusted for a peak
				junction temperature of + 1 5 0 $^{\circ}\mathrm{C}$
DOTA	Junction-to-	100		1 cubic fact chamban fue a sim
RθJA	Ambient	100		1 cubic foot chamber,free air.

OFF Characteristics TJ= 25[°]C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BVDSS	Drain- to- source Breakdown Voltage				V	VGS=0V,ID=250μA
IDSS	Drain- to- Source Leakage Current			1	μΑ	VDS=500V,VGS=0 V
	Gate- to- Source Forward Leakage			100		VGS=30V,VDS=0V
IGSS	Gate- to- Source Reverse Leakage			-100	nA	VGS=-30V ,VDS=0 V

ON Characteristics TJ=25 °C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
RDS(on)	Static Drain- to- Source On- Resistance(Note*2)		1.1	1.5	Ω	VGS=10V,ID=3.5A
VGS(TH)	Gate Threshold Voltage	3		4	V	VGS=VDS,ID=250μ A

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter		Тур.	Max.	Units	Test Conditions	
td(ON)	Turn- on Delay Time		35				
trise	Rise Time		7		C	VDS=250V ID=7A	
td(OFF)	Turn- OFF Delay Time		76		nS	RG=25Ω	
tfall	Fall Time		29				



Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Ciss	Input Capacitance		680			VGS=0V
Coss	Output Capacitance		73		pF	VDS=25V
Crss	Reverse Transfer Capacitance		7.2			f=1.0MHz
Qg	Total Gate Charge		20			VDS=400V
Qgs	Gate- to- Source Charge		3		nC	ID=7A
Qgd	Gate-to-Drain(" Miller") Charge		10			VGS=10V

Source-Drain Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
IS	Continuous Source Current			7	Α	Integral pn- diode
ISM	Maximum Pulsed Current			28	Α	in MOSFET
VSD	Diode Forward Voltage			1.4	٧	IS=3.5A,VGS=0V
trr	Reverse Recovery Time		100		nS	VR=250V
Qrr	Reverse Recovery Charge		0.23		μC	IS=3.5A,di/dt=100 A/μs

Notes:

^{* 1.} Repetitive rating, pulse width limited by maximum junction temperature.

^{* 2.} Pulse Test: Pulse width ≤ 300μs, Duty Cycle ≤ 1%



Typical Feature Curve

Figure 1. Output Characteristics (T_J = 25°C)

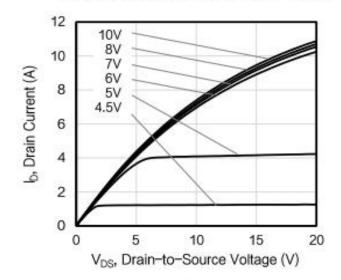


Figure 3. Drain Current vs. Temperature

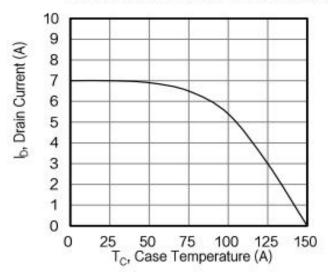


Figure 5. Transfer Characteristics

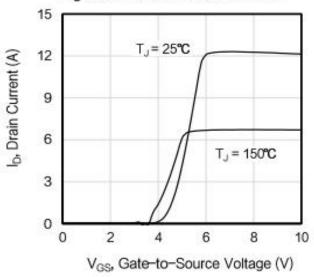


Figure 2. Body Diode Forward Voltage

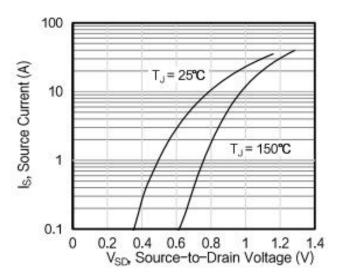


Figure 4. BV_{DSS} Variation vs. Temperature

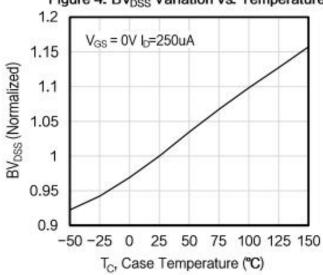
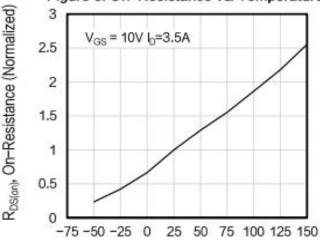
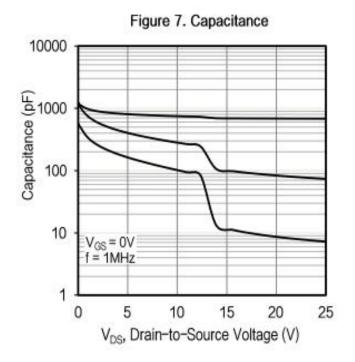


Figure 6. On-Resistance vs. Temperature



T_J, Junction Temperature (°C)



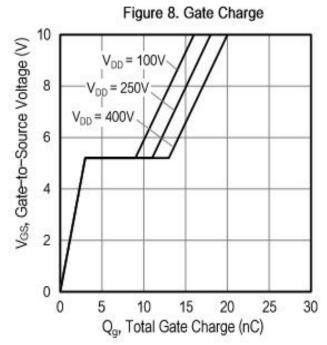


Figure 9. Transient Thermal Impedance

1E+1

(WY)

1E+0

D=0.5

D=0.2

D=0.1

D=0.05

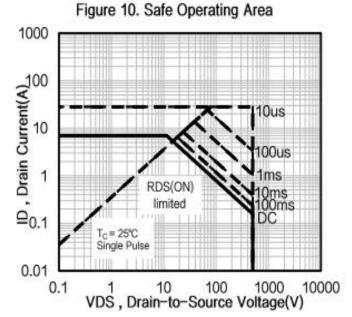
D=0.05

D=0.02

D=0.01

Single
Pulse

T_p, Pulse Width (s)





Test Circuits and Waveforms

Figure A: Gate Charge Test Circuit and Waveform

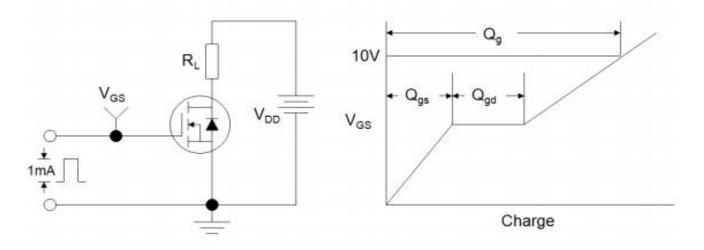


Figure B: Resistive Switching Test Circuit and Waveform

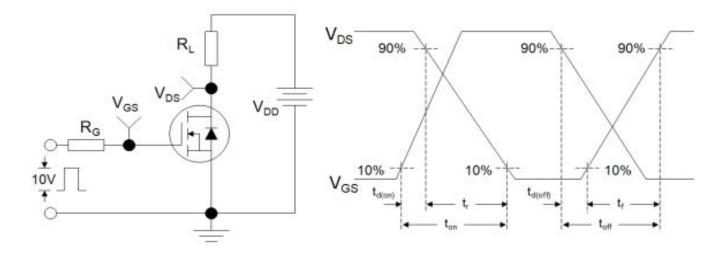
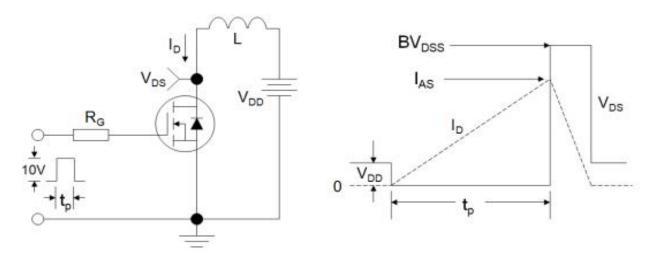
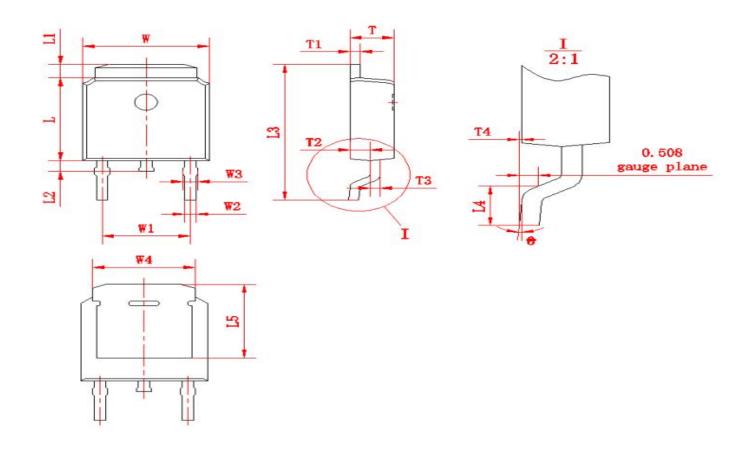


Figure C: Unclamped Inductive Switching Test Circuit and Waveform





Package outline drawing(TO-252 Unit: mm)



符号	尺寸		7/2 P.	尺寸		<i>5</i> 55 □	尺寸	
ी की च	Min	Max	符号	Min	Max	符号	Min	Max
W	6.50	6.70	L1	0.80	1.20	T1	0.48	0.58
W1	L (4.572)		L2	0.60	1.00	T2	0.95	1.15
W2	0.6	0.8	L3	9.70	10.30	Т3	0.48	0.58
W3	0.68	0.88	L4	1.30	1.70	T4	0.00	0.12
W4	(5	.3)	L5	(5.20)		0	0	8
L	6.00	6.20	Т	2.20	2.40			



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